**TOSHIBA** 2SC5321

### **TENTATIVE**

TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

# 2 S C 5 3 2 1

VHF~UHF BAND LOW NOISE AMPLIFIER APPLICATIONS

(CHIP:  $f_T = 16GHz$  series)

Low Noise Figure: NF=1.4dB (f=2GHz) :  $|S_{21e}|^2 = 10dB (f = 2GHz)$ High Gain

#### MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	$v_{CBO}$	8	V
Collector-Emitter Voltage	$v_{CEO}$	5	V
Emitter-Base Voltage	$ m v_{EBO}$	1.5	V
Collector Current	$_{ m I_C}$	10	mA
Base Current	$I_{\mathrm{B}}$	5	mA
Collector Power Dissipation	$P_{\mathbf{C}}$	100	mW
Junction Temperature	$T_{j}$	125	$^{\circ}\mathrm{C}$
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	°C

# **MARKING**



# Unit in mm 2.1 ± 0.1 1.25 ± 0.1 BASE **EMITTER** COLLECTOR **JEDEC** SC-70 **EIAJ TOSHIBA** 2-2E1A

Weight: 0.006g

# MICROWAVE CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Transition Frequency	${ m f_T}$	$V_{CE}=3V, I_{C}=7mA$	9	_	_	GHz
Incortion (ioin	$ S_{21e} ^2(1)$	$V_{CE}=3V$ , $I_{C}=7mA$ , $f=1GHz$	_	15.5	_	dB
	$ S_{21e} ^2$ (2)	$V_{CE}=3V$ , $I_{C}=7mA$ , $f=2GHz$	_	10	_	
I Noise Rigure	NF (1)	$V_{CE}$ =3V, $I_{C}$ =3mA, f=1GHz	_	0.9	1.8	dB
	NF (2)	$V_{CE}=3V$ , $I_{C}=3mA$ , $f=2GHz$	_	1.4	2.3	

### ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	ICBO	$V_{CB}=10V, I_{E}=0$	_	_	1	$\mu$ A
Emitter Cut-off Current	$I_{EBO}$	$V_{EB}=1V, I_{C}=0$	_	_	1	$\mu$ A
DC Current Gain	$_{ m h_{FE}}$	$V_{CE}=3V, I_{C}=7mA$	50	_	250	V
Output Capacitance	$C_{ob}$	$V_{CB} = 2.5V, I_{E} = 0, f = 1MHz$	_	0.45	_	pF
Reverse Transfer Capacitance	$\mathrm{C_{re}}$	(Note)		0.35	_	pF

(Note)  $C_{re}$  is measured by 3 terminal method with Capacitance bridge. **CAUTION** 

This device electrostatic sensitivity. Please handle with caution.

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  TOSHIBA Semiconductor Reliability Handbook.

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